

Notice of References Cited	Application/Control No. 10/664,436		Applicant(s)/Patent Under Reexamination FUJII ET AL.	
	Examiner PAUL S. HYUN		Art Unit 1797	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0155010 A1	10-2002	Karp et al.	417/413.2
*	B	US-6,458,325 B1	10-2002	Roscher et al.	422/68.1
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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